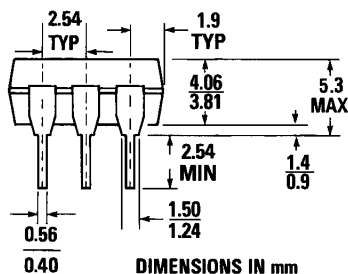
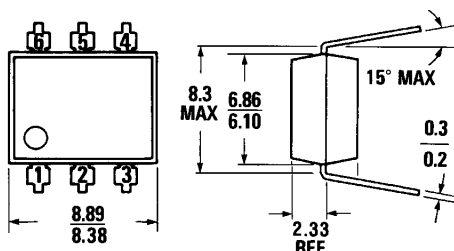
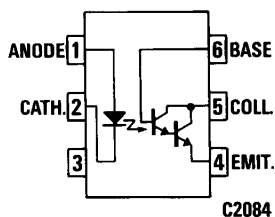


PACKAGE DIMENSIONS



DIMENSIONS IN mm
PACKAGE CODE K

ST1603A



Equivalent Circuit

DESCRIPTION

The 4N32 and 4N33 have a gallium arsenide infrared emitter optically coupled to a silicon planar photodarlington.

FEATURES & APPLICATIONS

- High isolation resistance— $10^{11}\Omega$
- High dielectric strength, input to output 5300 V RMS—1 minute
- Low coupling capacitance—1.0 pF
- Convenient package—plastic dual-in-line
- Long lifetime, solid state reliability
- Low weight—0.4 grams
- UL recognized—File E90700

ABSOLUTE MAXIMUM RATINGS ($T_A=25^\circ\text{C}$ Unless Otherwise Specified)

TOTAL PACKAGE

- *Storage temperature -55°C to 150°C
- *Operating temperature at junction -55°C to 100°C
- *Lead soldering time @ 260°C 10 seconds
- *Total power dissipation at 25°C ambient 250 mW
- *Derate linearly from 25°C 3.3 mW/ $^\circ\text{C}$

INPUT DIODE

- *Power dissipation @ 25°C ambient 150 mW
- *Derate linearly from 55°C 2 mW/ $^\circ\text{C}$
- *Continuous forward current 80 mA
- Reverse current 10 mA
- *Peak forward current
(300 μsec , 2% duty cycle) 3.0 A

*Indicated JEDEC Registered data.

OUTPUT TRANSISTOR

- *Power dissipation @ 25°C ambient 150 mW
- *Derate linearly from 25°C 2.0 mW/ $^\circ\text{C}$
- *Collector-emitter breakdown voltage (BV_{CE0}) ... 30 V
- *Collector-base breakdown voltage (BV_{CB0}) 50 V
- *Emitter-base breakdown voltage (BV_{EB0}) 8.0 V
- *Emitter-collector breakdown voltage (BV_{EC0}) 5 V

ELECTRO-OPTICAL CHARACTERISTICS (25°C Unless Otherwise Specified)

INDIVIDUAL COMPONENT CHARACTERISTICS

CHARACTERISTIC	SYMBOL	MIN.	TYP.	MAX.	UNIT	TEST CONDITION
DIODE ($T_A = 25^\circ\text{C}$ unless otherwise noted)						
*Reverse leakage current	I_R		0.05	100	μA	$V_A = 3.0\text{ V}$
*Forward voltage	V_F		1.2	1.5	Volts	$I_F = 10\text{ mA}$
Capacitance	C		150		pF	$V_F = 0\text{ V}$, $f = 1.0\text{ MHz}$
DETECTOR ($T_A = 25^\circ\text{C}$ and $I_F = 0$ unless otherwise noted)						
*Collector-emitter dark current	I_{CEO}			100	nA	$V_{CE} = 10\text{ V}$, base open
*Collector-base breakdown voltage	BV_{CBO}	30			Volts	$I_C = 100\text{ }\mu\text{A}$, $I_E = 0$
*Collector-emitter breakdown voltage	BV_{CEO}	30			Volts	$I_C = 100\text{ }\mu\text{A}$, $I_B = 0$
*Emitter-collector breakdown voltage	BV_{ECO}	5.0			Volts	$I_E = 100\text{ }\mu\text{A}$, $I_B = 0$
DC current gain	h_{FE}		5000			$V_{CE} = 5.0\text{ V}$, $I_C = 500\text{ }\mu\text{A}$

TRANSFER CHARACTERISTICS

DC CHARACTERISTICS	SYMBOL	MIN.	TYP.	MAX.	UNIT	TEST CONDITION
(T _A = 25°C unless otherwise noted)						
*Collector output current (Note 1) 4N32, 4N33	I_C	50			mA	$V_{CE} = 10\text{ V}$, $I_F = 10\text{ mA}$, $I_B = 0$
*Collector-emitter saturation voltage (1) 4N32, 4N33	$V_{CE(SAT)}$			1.0	Volts	$I_C = 2.0\text{ mA}$, $I_F = 8.0\text{ mA}$

TRANSFER CHARACTERISTICS

AC CHARACTERISTICS	SYMBOL	MIN.	TYP.	MAX.	UNIT	TEST CONDITION
(Fig. 6 and 7)						
Turn-on time	t_{ON}		0.6	5.0	μs	$I_C = 50\text{ mA}$, $I_F = 200\text{ mA}$, $V_{CC} = 10\text{ V}$
Turn-off time 4N32, 4N33	t_{OFF}		45	100	μs	$V_{CC} = 10\text{ V}$
Bandwidth (3)			30		kHz	

ISOLATION CHARACTERISTICS

CHARACTERISTICS	SYMBOL	MIN.	TYP.	MAX.	UNIT	TEST CONDITION
Isolation capacitance (Note 2)			0.8		pF	$V = 0$, $f = 1.0\text{ MHz}$
Isolation voltage (Note 2) 4N32, 4N33	V_{ISO}	5300	—	—	V	$I_{F0} \leq 1\text{ }\mu\text{A}$ V_{RMS} , $t = 1\text{ minute}$
* (4N32)		2500	—	—	V	VDC
* (4N33)		1500	—	—	V	VDC
Isolation resistance (Note 2)	R_{ISO}		10^{11}		Ohms	$V = 500\text{ VDC}$

*Indicates JEDEC Registered Data.

(1) Pulse test: pulse width = 300 μs , duty cycle $\leq 2.0\%$

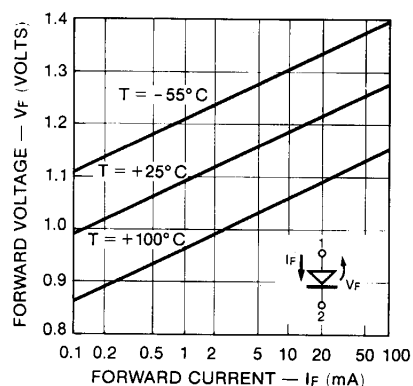
(2) For this test LED pins 1 and 2 are common and phototransistor pins 4, 5 and 6 are common.

(3) I_F adjusted to $I_C = 2.0\text{ mA}$ and $i_C = 0.7\text{ mA RMS}$.

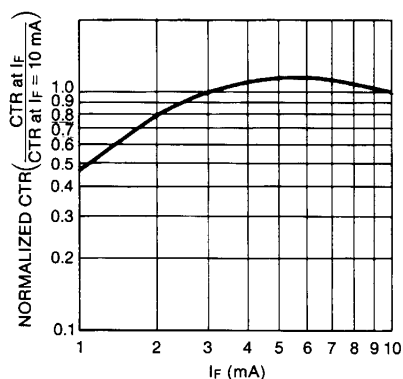
(4) t_r and t_f are inversely proportional to the amplitude of I_F ; t_r and t_f are not significantly affected by I_F .

TYPICAL ELECTRO-OPTICAL CHARACTERISTIC CURVES

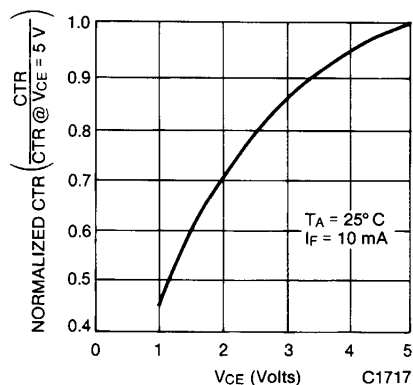
(25°C Free Air Temperature Unless Otherwise Specified)



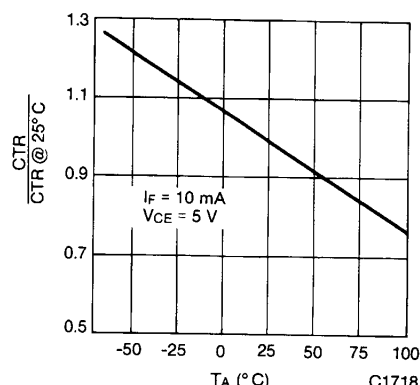
C1686



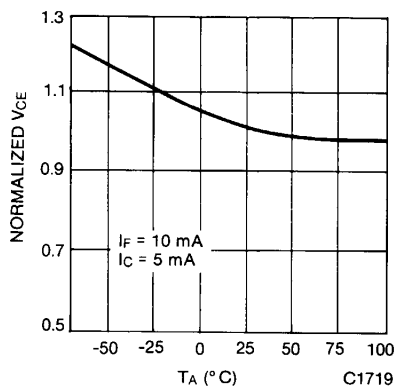
C1894



C1717



C1718



C1719

TYPICAL ELECTRO-OPTICAL CHARACTERISTIC CURVES

(25°C Free Air Temperature Unless Otherwise Specified) (Cont'd)

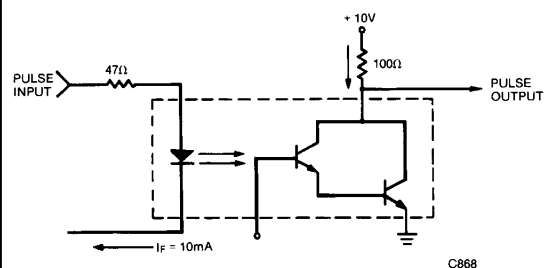


Fig. 6. Test Circuit

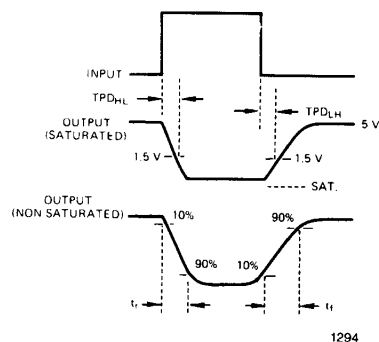


Fig. 7. Switching Waveforms

NOTES

1. The current transfer ratio (I_c/I_F) is the ratio of the detector collector current to the LED input current with V_{CE} at 10 volts.
2. The frequency at which i_c is 3dB down from the 1 kHz value.
3. t_{on} is measured from 10% of the leading edge of the input pulse to the 90% point on the leading edge of the output pulse. t_{off} is measured from 90% of the trailing edge of the input pulse to the 10% point on the trailing edge of the output pulse.